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Application/Control	No.

Applicant(s)/Patent under Reexamination

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Examiner

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Art Unit

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SEARCHED				
Class	Subclass	Date	Examiner	
713	300-340	9/22/2006	cs	
710	72-74	9/22/2006	cs	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
713	324	3/31/2007	cs	
710	72	3/31/2007	cs	
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SEARCH NOT (INCLUDING SEARCH		·)
	DATE	EXMR
PLUS	9/22/2006	cs
PALM (Double Patenting)	9/22/2006	cs
EAST (See Search Notes)	9/22/2006	cs
EAST (US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBMTDB)	3/31/2007	cs
PALM (Double Patenting)	3/31/2007	cs
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